SIPMOS® Power-Transistor

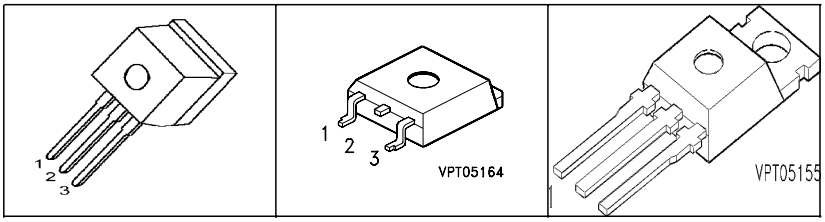
Feature

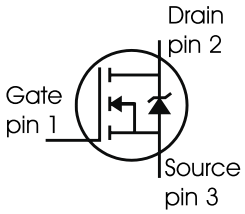
- N-Channel
- Enhancement mode
- 175°C operating temperature
- Avalanche rated
- d*v*/d*t* rated

Product Summary

V_{DS}	100	V
$R_{DS(on)}$	44	mΩ
I_D	35	A

P-TO262-3-1 P-TO263-3-2 P-TO220-3-1





Type	Package	Ordering Code	Marking
SPP35N10	P-TO220-3-1	Q67042-S4123	35N10
SPB35N10	P-TO263-3-2	Q67042-S4103	35N10
SPI35N10	P-TO262-3-1	Q67042-S4124	35N10

Maximum Ratings,at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current	I_D		A
T_C=25°C		35	
T_C=100°C		26.4	
Pulsed drain current	$I_{D\ puls}$	140	
T_C=25°C			
Avalanche energy, single pulse	E_{AS}	245	mJ
I_D=35 A , V_{DD}=25V, R_{GS}=25Ω			
Reverse diode d*v*/d*t*	d*v*/d*t*	6	kV/µs
I_S=35A, V_{DS}=80V, d*i*/d*t*=200A/µs, T_{jmax}=175°C			
Gate source voltage	V_{GS}	±20	V
Power dissipation	P_{tot}	150	W
T_C=25°C			
Operating and storage temperature	T_j , T_{stg}	-55... +175	°C
IEC climatic category; DIN IEC 68-1		55/175/56	

Thermal Characteristics

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Characteristics					
Thermal resistance, junction - case	R_{thJC}	-	-	1	K/W
Thermal resistance, junction - ambient, leaded	R_{thJA}	-	-	62	
SMD version, device on PCB:	R_{thJA}				
@ min. footprint		-	-	62	
@ 6 cm^2 cooling area [F)]		-	-	40	

Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
Static Characteristics					
Drain-source breakdown voltage V_{GS}=0V, I_D=1mA	$V_{(BR)DSS}$	100	-	-	V
Gate threshold voltage, V_{GS} = V_{DS} I_D=83µA	$V_{GS(th)}$	2.1	3	4	
Zero gate voltage drain current	I_{DSS}				µA
V_{DS}=100V, V_{GS}=0V, T_j=25°C		-	0.01	1	
V_{DS}=100V, V_{GS}=0V, T_j=125°C		-	1	100	
Gate-source leakage current V_{GS}=20V, V_{DS}=0V	I_{GSS}	-	1	100	nA
Drain-source on-state resistance V_{GS}=10V, I_D=26.4A	$R_{DS(on)}$	-	36	44	mΩ

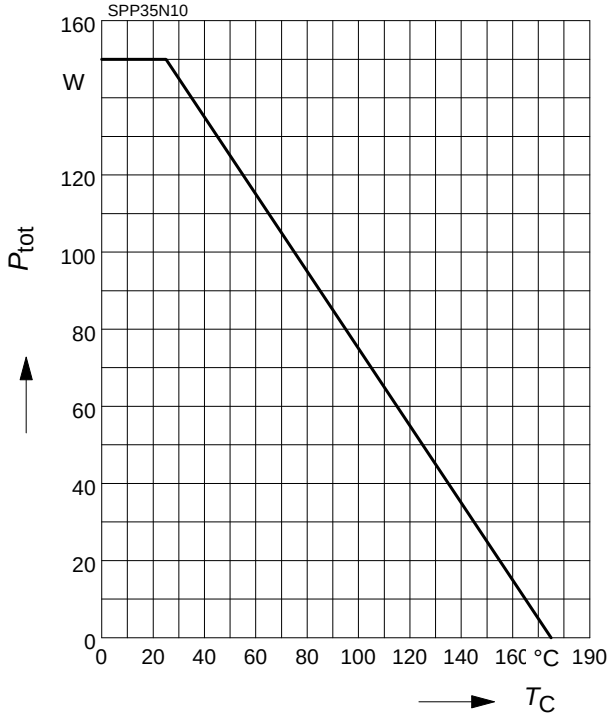
[1]Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic Characteristics						
Transconductance	g_{fs}	$V_{DS}\geq 2*I_D*R_{DS(on)max}$, I_D=26.4A	12	23	-	S
Input capacitance	C_{iss}	V_{GS}=0V, V_{DS}=25V, f=1MHz	-	1180	1570	pF
Output capacitance	C_{oss}		-	245	326	
Reverse transfer capacitance	C_{rss}		-	137	206	
Turn-on delay time	$t_{d(on)}$	V_{DD}=50V, V_{GS}=10V, I_D=35A, R_G=7Ω	-	12.2	18.3	ns
Rise time	t_r		-	63	95	
Turn-off delay time	$t_{d(off)}$		-	39	59	
Fall time	t_f		-	23	34	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}	V_{DD}=80V, I_D=35A	-	6.5	8.6	nC
Gate to drain charge	Q_{gd}		-	27	41	
Gate charge total	Q_g	V_{DD}=80V, I_D=35A, V_{GS}=0 to 10V	-	49	65	
Gate plateau voltage	$V_{(plateau)}$	V_{DD}=80V, I_D=35A	-	6.1	-	V
Reverse Diode						
Inverse diode continuous forward current	I_S	T_C=25°C	-	-	35	A
Inverse diode direct current, pulsed	I_{SM}		-	-	140	
Inverse diode forward voltage	V_{SD}	V_{GS}=0V, I_F=35A	-	0.95	1.25	V
Reverse recovery time	t_{rr}	V_R=50V, I_F=I_S, di_F/dt=100A/µs	-	80	100	ns
Reverse recovery charge	Q_{rr}		-	230	290	nC

1 Power dissipation

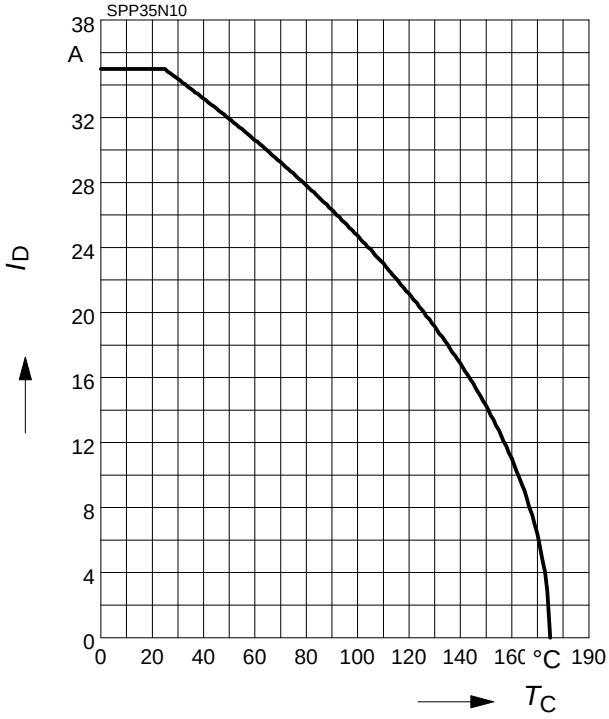
$P_{tot} = f(T_C)$



2 Drain current

$I_D = f(T_C)$

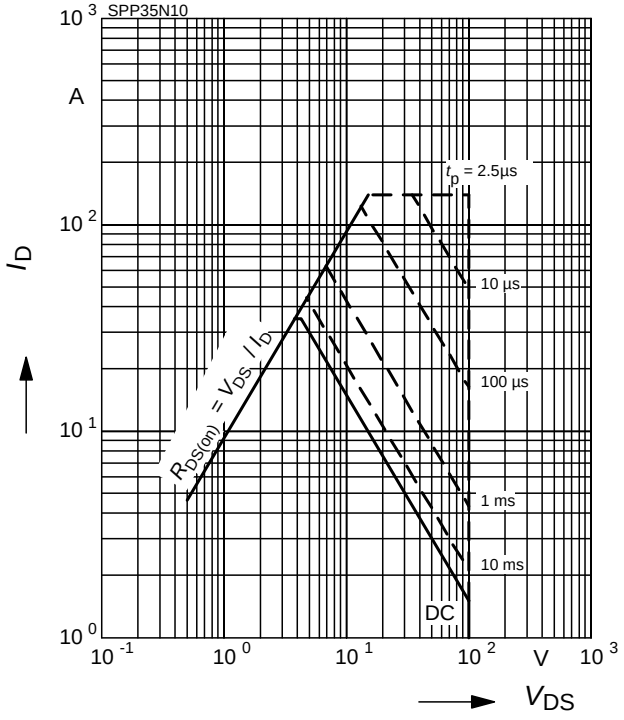
parameter: $V_{GS} \geq 10$ V



3 Safe operating area

$I_D = f(V_{DS})$

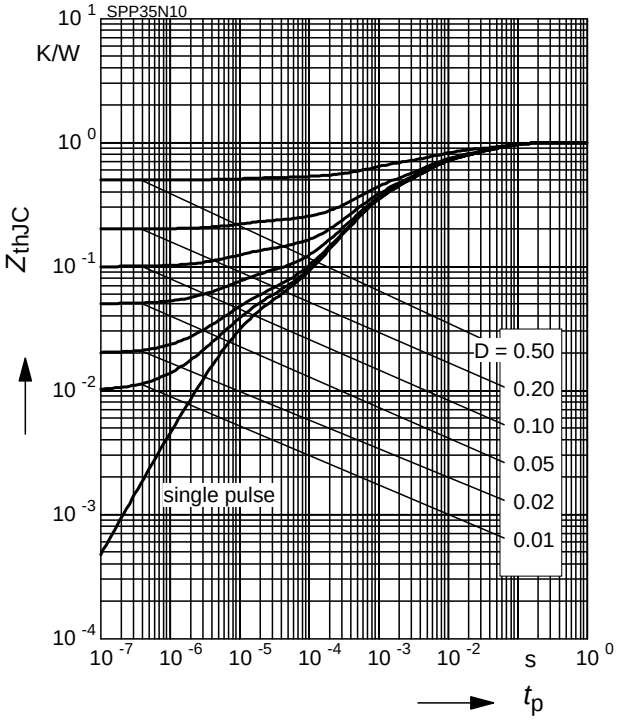
parameter : $D = 0$, $T_C = 25$ °C



4 Transient thermal impedance

$Z_{thJC} = f(t_p)$

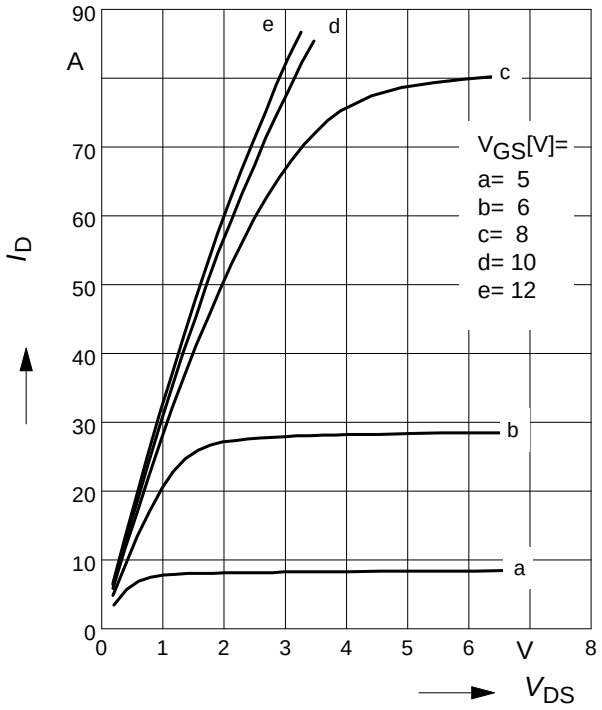
parameter : $D = t_p/T$



5 Typ. output characteristic

$I_D = f(V_{DS})$; T_j=25°C

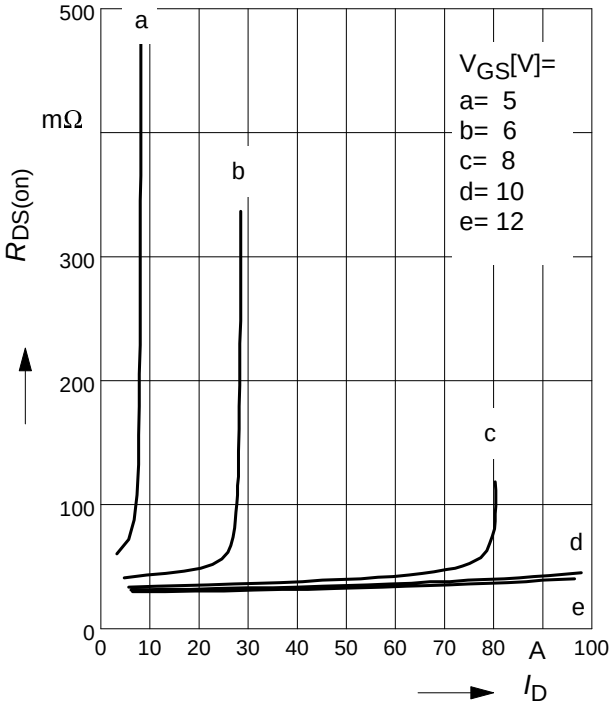
parameter: t_p = 80 µs



6 Typ. drain-source on resistance

$R_{DS(on)} = f(I_D)$

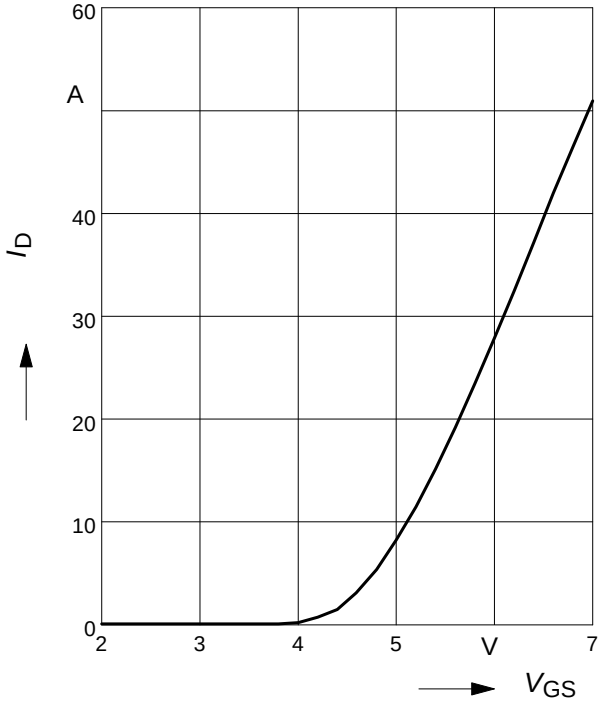
parameter: V_{GS}



7 Typ. transfer characteristics

$I_D = f(V_{GS})$; $V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$

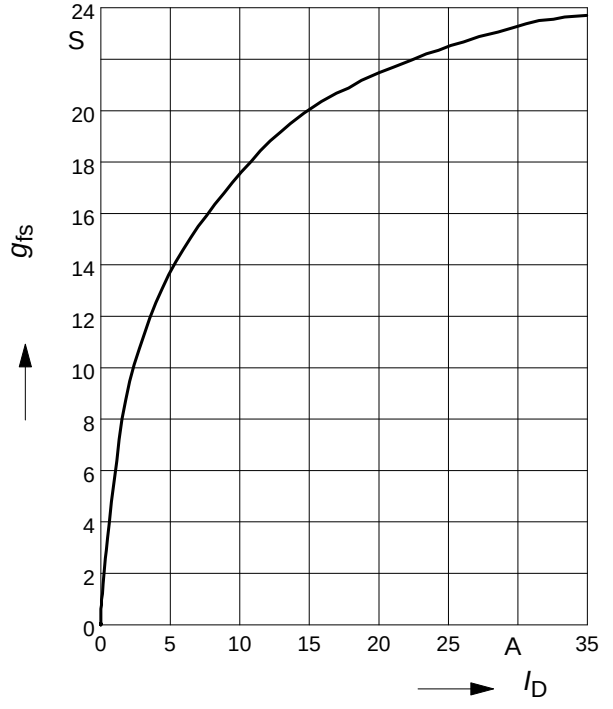
parameter: t_p = 80 µs



8 Typ. forward transconductance

g_{fs} = f(I_D); T_j=25°C

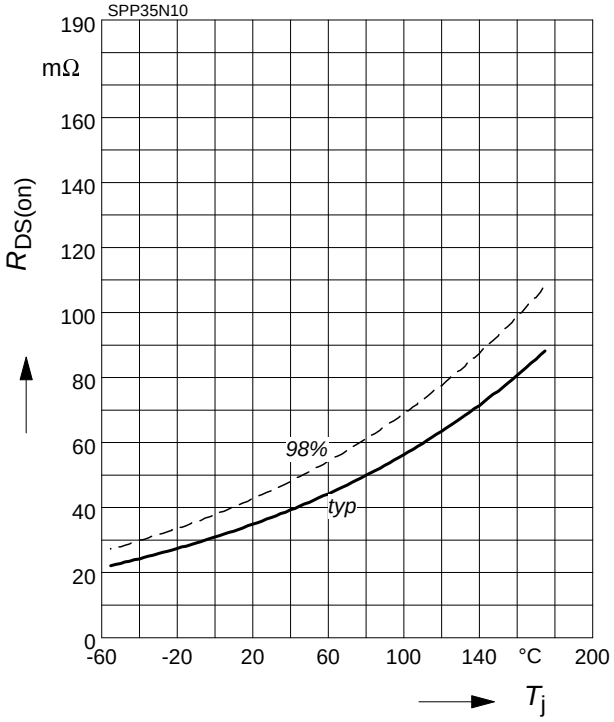
parameter: g_{fs}



9 Drain-source on-state resistance

$R_{DS(on)} = f(T_j)$

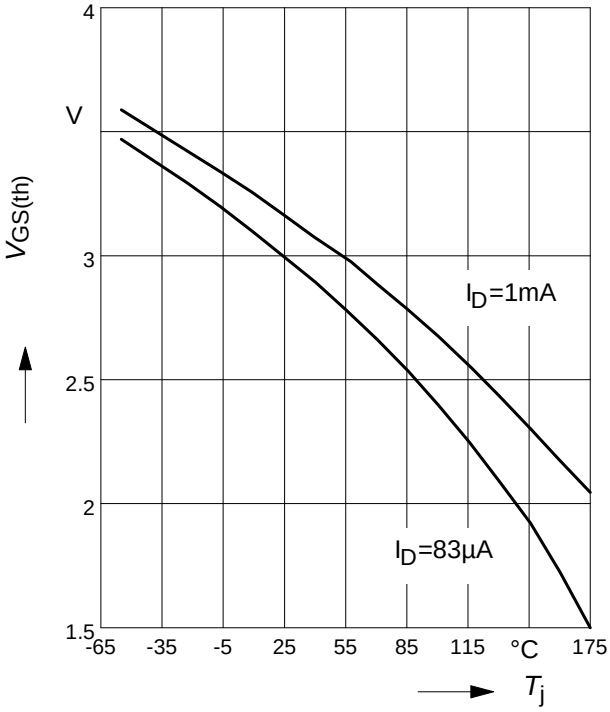
parameter : I_D = 26.4 A, V_{GS} = 10 V



10 Typ. gate threshold voltage

$V_{GS(th)} = f(T_j)$

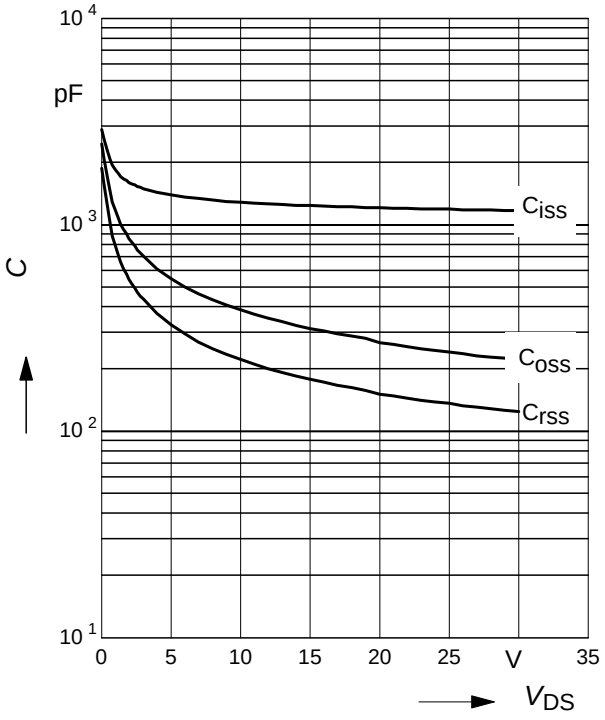
parameter: $V_{GS} = V_{DS}$



11 Typ. capacitances

$C = f(V_{DS})$

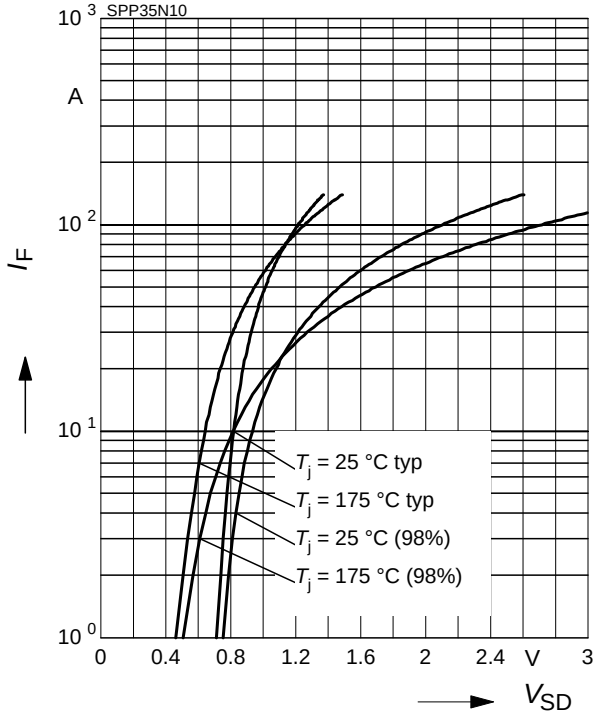
parameter: V_{GS}=0V, f=1 MHz



12 Forward character. of reverse diode

$I_F = f(V_{SD})$

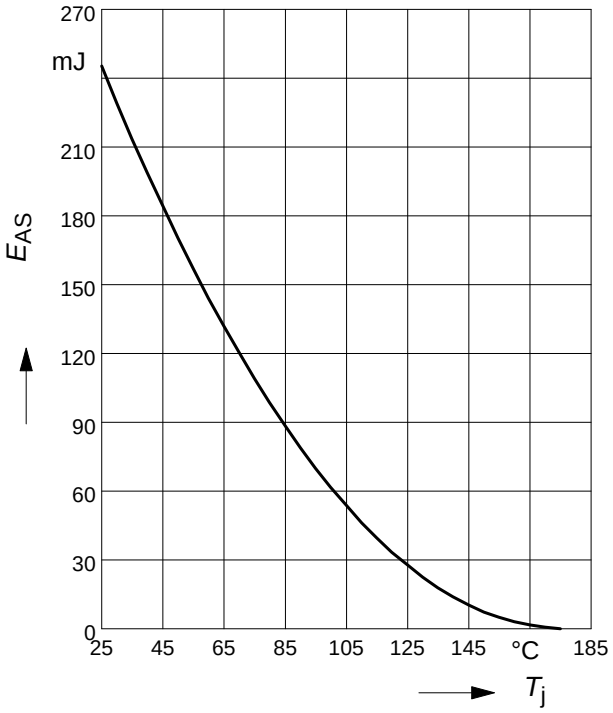
parameter: T_j , tp = 80 µs



11 Typ. avalanche energy

$E_{AS} = f(T_j)$

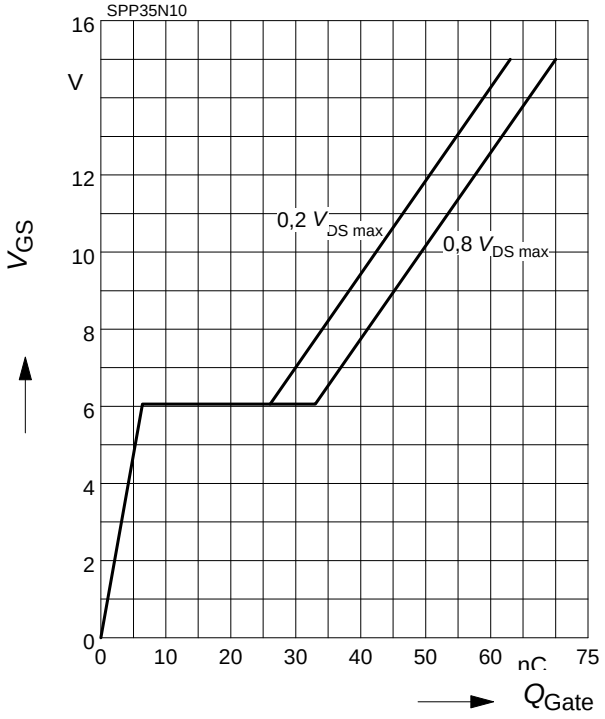
par.: I_D = 35 A , V_{DD} = 25 V, R_{GS} = 25 Ω



12 Typ. gate charge

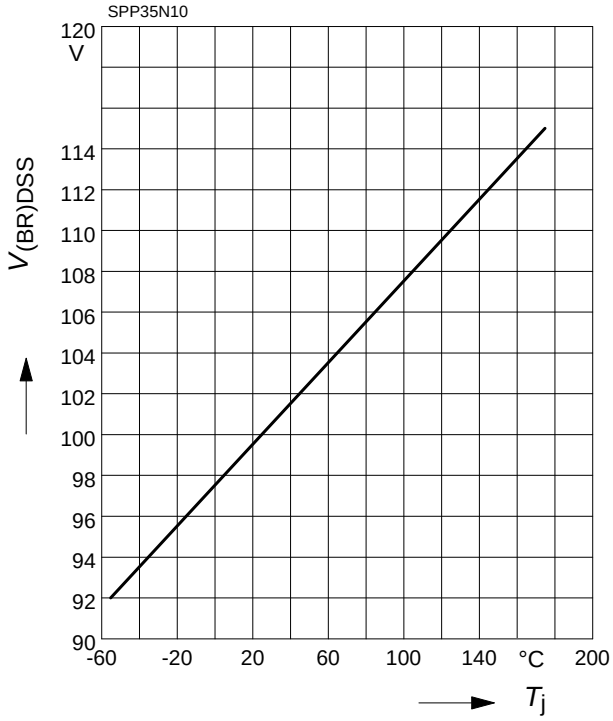
$V_{GS} = f\ (Q_{Gate})$

parameter: I_D = 35 A pulsed



13 Drain-source breakdown voltage

$V_{(BR)DSS} = f(T_j)$



Published by
Infineon Technologies AG,
Bereichs Kommunikation
St.-Martin-Strasse 53,
D-81541 München
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